

Notice of References Cited	Application/Control No. 10/713,271	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner Philip H Leung	Art Unit 3742

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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B	US-4,184,945	01-1980	Morgan et al.	219/757
C	US-5,945,023	08-1999	Yang, Ha-yeong	219/756
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K	US-			
L	US-			
M	US-			

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N	63-127026	05-1988	JP	Sakurai	----
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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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